


<b>Search Notes</b> 	<b>Application/Control No.</b> 10539609	<b>Applicant(s)/Patent Under Reexamination</b> ARAKI ET AL.
	<b>Examiner</b> HIEN X VO	<b>Art Unit</b> 2863

SEARCHED			
Class	Subclass	Date	Examiner
702	190/189/195/196	05/08/08	VXH
375	377/232	05/08/08	VXH
704	203/205	05/08/08	VXH

SEARCH NOTES			
Search Notes		Date	Examiner
PLUS		05/08/08	VXH
EAST		05/08/08	VXH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
702	190/189/195/196	05/08/08	VXH
375	232/377	05/08/08	VXH
704	203/205	05/08/08	VXH